

N-CHANNEL MOS FET  
FOR HIGH-SPEED SWITCHING

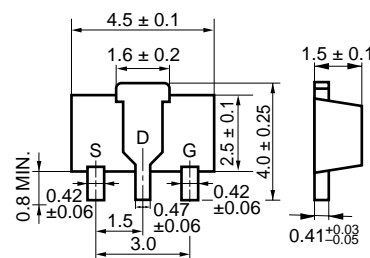
The 2SK2111 is a N-channel MOS FET of a vertical type and is a switching element that can be directly driven by the output of an IC operating at 5 V.

This product has a low ON resistance and superb switching characteristics and is ideal for driving the actuators, such as motors and DC/DC converters.

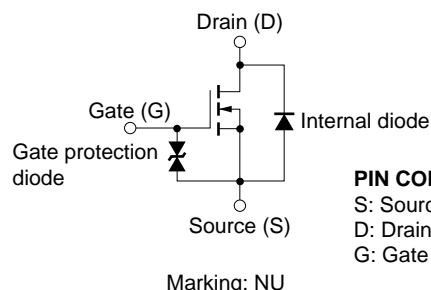
FEATURES

- Low ON resistance  
 $R_{DS(on)} = 0.6 \Omega$  MAX. @  $V_{GS} = 4.0 V$ ,  $I_D = 0.5 A$
- High switching speed  
 $t_{on} + t_{off} < 100 ns$
- Low parasitic capacitance

PACKAGE DIMENSIONS (in mm)



EQUIVALENT CIRCUIT



PIN CONNECTIONS

- S: Source
- D: Drain
- G: Gate

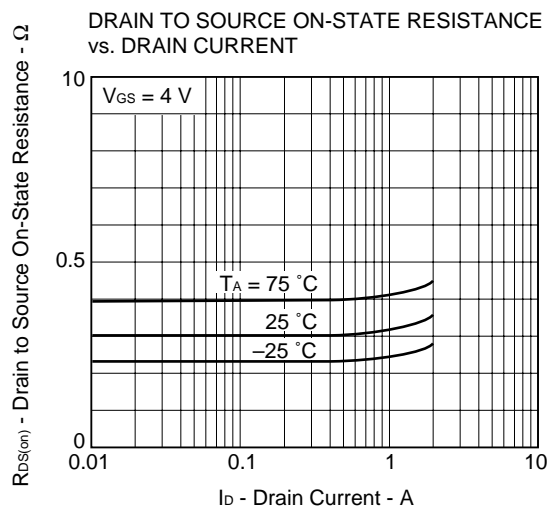
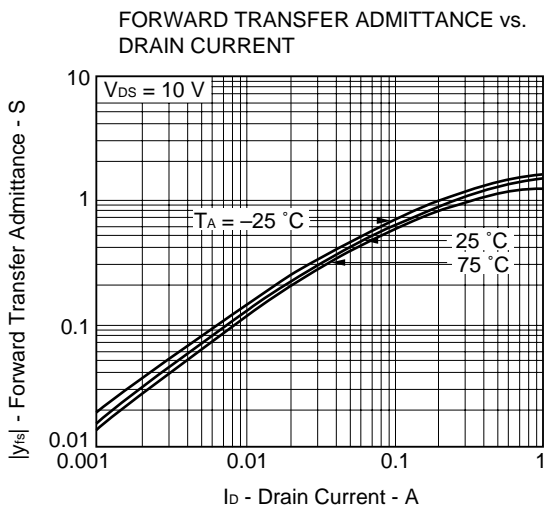
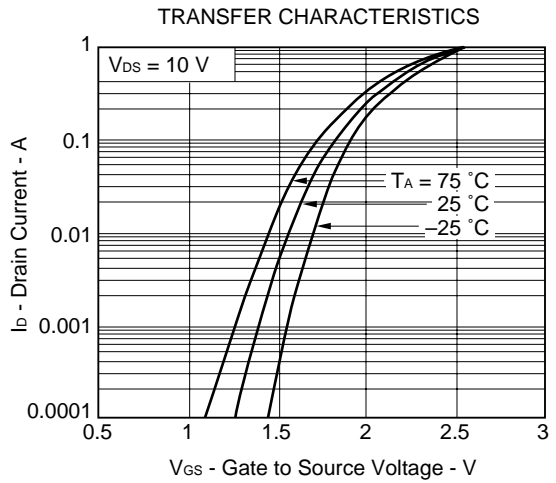
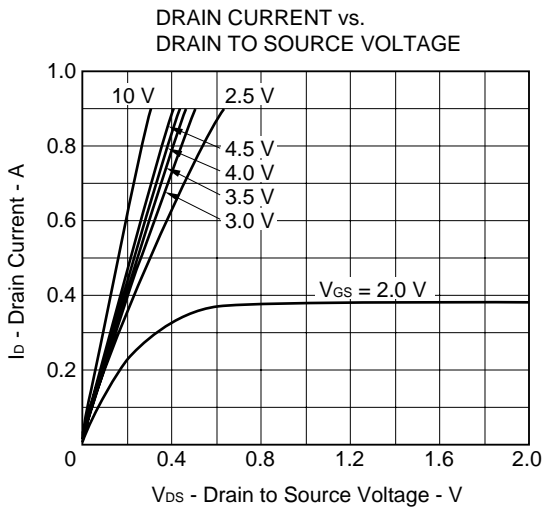
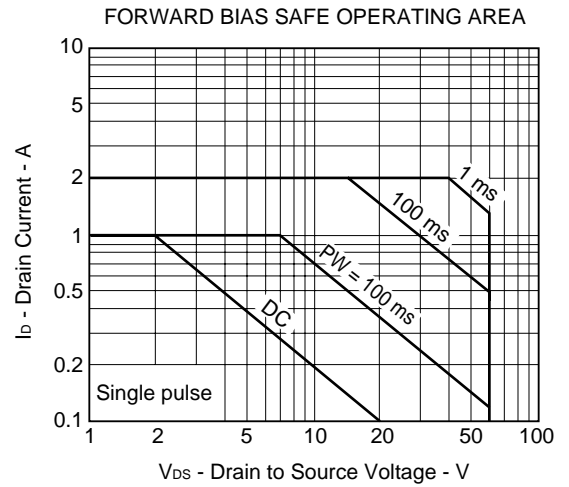
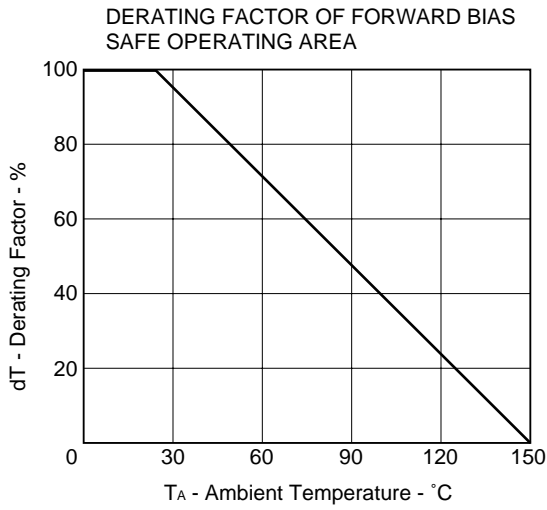
ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ )

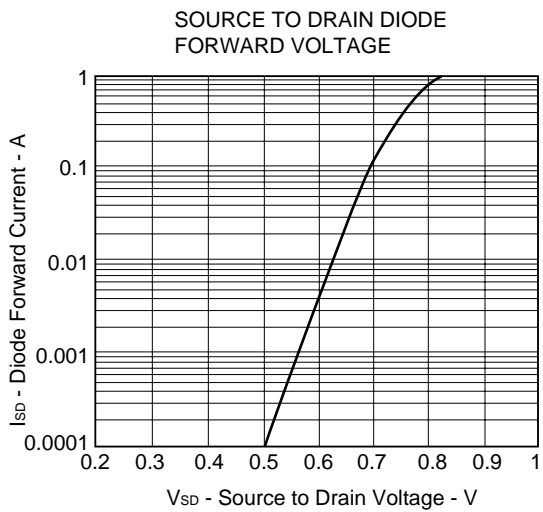
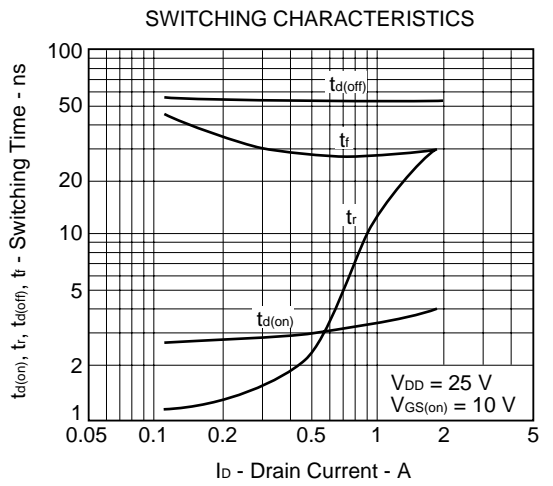
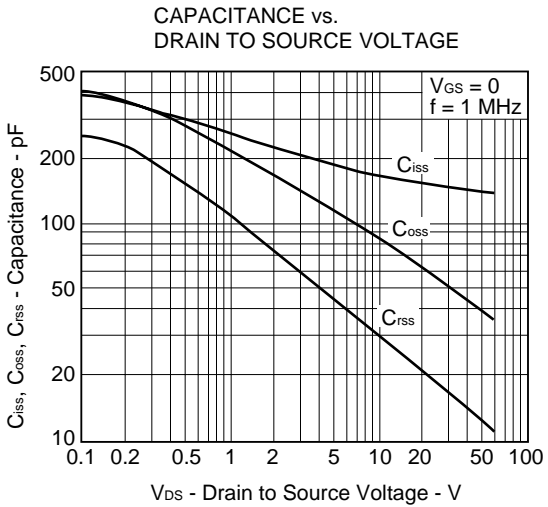
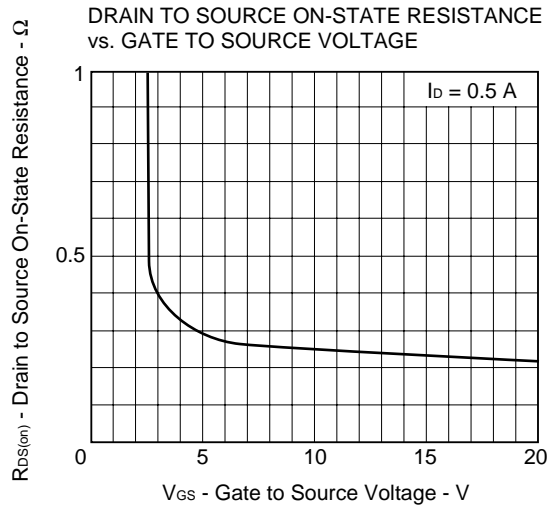
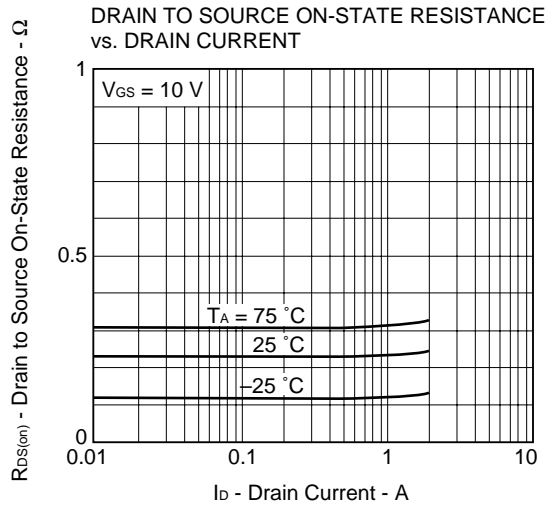
PARAMETER	SYMBOL	TEST CONDITIONS	RATING	UNIT
Drain to Source Voltage	$V_{DSS}$	$V_{GS} = 0$	60	V
Gate to Source Voltage	$V_{GSS}$	$V_{DS} = 0$	$\pm 20$	V
Drain Current (DC)	$I_{D(DC)}$		$\pm 1.0$	A
Drain Current (Pulse)	$I_{D(pulse)}$	$PW \leq 10 ms$ , Duty cycle $\leq 50 \%$	$\pm 2.0$	A
Total Power Dissipation	$P_T$	$16 cm^2 \times 0.7 mm$ , ceramic substrate used	2.0	W
Channel Temperature	$T_{ch}$		150	$^\circ C$
Storage Temperature	$T_{stg}$		-55 to +150	$^\circ C$

**ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C)**

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-Off Current	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0			1.0	μA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0			±10	μA
Gate Cut-Off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	0.8	1.4	2.0	V
Forward Transfer Admittance	y <sub>ts</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.5 A	0.4			S
Drain to Source On-State Resistance	R <sub>DS(on)1</sub>	V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 0.5 A		0.32	0.6	Ω
Drain to Source On-State Resistance	R <sub>DS(on)2</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5 A		0.24	0.45	Ω
Input Capacitance	C <sub>iSS</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1.0 MHz		170		pF
Output Capacitance	C <sub>oSS</sub>			87		pF
Reverse Transfer Capacitance	C <sub>rSS</sub>			32		pF
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 25 V, I <sub>D</sub> = 0.5 A V <sub>GS(on)</sub> = 10 V, R <sub>G</sub> = 10 Ω R <sub>L</sub> = 50 Ω		2.8		ns
Rise Time	t <sub>r</sub>			2.3		ns
Turn-Off Delay Time	t <sub>d(off)</sub>			55		ns
Fall Time	t <sub>f</sub>			27		ns

TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C)





**REFERENCE**

Document Name	Document No.
NEC semiconductor device reliability/quality control system	TEI-1202
Quality grade on NEC semiconductor devices	IEI-1209
Semiconductor device mounting technology manual	C10535E
Guide to quality assurance for semiconductor devices	MEI-1202
Semiconductor selection guide	X10679E

## [MEMO]

No part of this document may be copied or reproduced in any form or by any means without the prior written consent of NEC Corporation. NEC Corporation assumes no responsibility for any errors which may appear in this document.

NEC Corporation does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from use of a device described herein or any other liability arising from use of such device. No license, either express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC Corporation or others.

While NEC Corporation has been making continuous effort to enhance the reliability of its semiconductor devices, the possibility of defects cannot be eliminated entirely. To minimize risks of damage or injury to persons or property arising from a defect in an NEC semiconductor device, customer must incorporate sufficient safety measures in its design, such as redundancy, fire-containment, and anti-failure features.

NEC devices are classified into the following three quality grades:

“Standard”, “Special”, and “Specific”. The Specific quality grade applies only to devices developed based on a customer designated “quality assurance program” for a specific application. The recommended applications of a device depend on its quality grade, as indicated below. Customers must check the quality grade of each device before using it in a particular application.

Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices in “Standard” unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact NEC Sales Representative in advance.

Anti-radioactive design is not implemented in this product.